



State-of-the-art in surface metrology for metal additive manufacturing

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Review paper



Surface texture metrology for additive manufacturing: a review (2016),

The University of Nottingham

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A. Townsend, N. Senin, L. Blunt, R. Leach, J. Taylor,

Precision Engineering, 46. pp. 34-47. ISSN 0141-6359

Metal AM



Material	EBM	Laser	DED
Nickel alloys	0	100%	0
Aluminium alloys	0	100%	0
Stainless steels	0	87%	13%
Other steels	0	83%	17%
Titanium alloys	35%	50%	15%
Others	0	100%	0

Material	%papers	
Nickel alloys	5%	(75% Inconel 625):
Aluminum alloys (e.g. AlSi10Mg)	5%	
Stainless steels	39%	(70% 316L)
Other steels	10%	
Titanium alloys (in particular: Ti6Al4V)	34%	(95% Ti6Al4V)
Others	7%	





Part I Role of surface metrology in AM research

Active AM projects 2015-2016 (RCUK)



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The current landscape of AM research -2016 ICL AMN report

Process capability assessment

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90% literature on metal AM uses artifacts







Application-specific / product-specific research?





AM markets by application



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The current landscape of AM research - 2016 ICL AMN report

In-process surface metrology



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Need to be quick, need access, need to operate in challenging conditions

Most 2.5D and 3D measurement techniques don't work

In-process surface metrology



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Other: (acoustic emissions, laser ultrasonics. Etc)

Defect "detection" (Y/N)





Part II Measurement of AM topography

Surface measurement pipeline

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Part II Measurement of AM topography What do AM surfaces look like?











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SLM_Cube_Z0002 2016-03-08 14:10 h D7.8 x200 500 μm



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SLM_Cube_Z0003 2016-03-08 14:12 h D7.5 x500 200 μm





















Part II Measurement of AM topography Technologies

Stylus profilometer



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40% of metal AM literature

Stylus problems



- Representativeness
- Traversal problems
- Damage



Optical areal measurement

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- Confocal Microscopy (%11)
- Focus Variation (%11)
- Coherence Scanning Interferometry (%7)

(Usage percentages form the PE review)

Optical areal measurement





X-ray Computed Tomography





Areal Measurement









Part III Characterisation of AM topography

Surface metrology pipeline





So many possibilities!





Texture parameters in AM surface metrology



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From the PE review:

80% papers on metal AM use profile parameters

Ra >>>> **Rq** >> **Rz**, **Rt** >>(others)...



The good old Ra



ISO 4287:1997

Ra – Arithmetical mean deviation of surface heights (on the roughness profile)



Texture parameters in AM surface metrology

From the PE review:

20% papers on metal AM use **areal parameters** (90% of which cite *Sa*)

ISO 25178-2 arithmetic mean height - Sa

$$Sa = \frac{1}{A} \iint_{A} |z(x, y)| dx dy$$





Scale-limited characterisation

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Choice criteria



- Study application/function
- Study mfg. process
- Study measurement
- Parallel with profiles?
- Intrinsic properties of the dataset

From the PE review:

90% papers using profile parameters indicate cut-offs 70% papers using areal parameters indicate cut-offs











Z. Reese, J. Taylor, C. Evans ASPE 2016

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A. Townsend, L. Blunt, PE review, 2016

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[N.Senin, L.Blunt, in: Charact. Srf. Texture, R.Leach (Ed), 2014]



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Part IV Open challenges Quality of acquired topography?

It does indeed look beautiful...









Part IV Open challenges What's relevant in topography?





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What scales?



Possibly, **no single answer** (Viewpoints are context dependent)





Part IV Open challenges New scenarios for surface metrology

AM markets by application



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The current landscape of AM research -2016 ICL AMN report

Do we know what to expect?



AM technologies inspire the creation of new designs

... forcing metrology to deal with unforeseen challenges

Lattice structures





Freedom of form



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No tool-access problems

Probe-access problems?

Multimaterial / embedded function



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Surfaces as interfaces between parts How to access if parts are built together?

The University of Nottingham Dimensional micro-metrology



III







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Thank you

Centre for Precision Technologies @ Huddersfield









The Manufacturing Metrology Team

Lawrence Livermore National Laboratory

Advanced Manufacturing Technology Research Group



